

FDPF8N50NZF

N-Channel UniFETTM II FRFET[®] MOSFET 500 V, 7 A, 1 Ω

Features

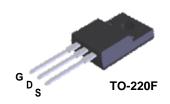
- $R_{DS(on)}$ = 850 m Ω (Typ.) @ V_{GS} = 10 V, I_D = 3.25 A
- Low Gate Charge (Typ. 14 nC)
- Low C_{rss} (Typ. 5 pF)
- 100% Avalanche Tested
- Improve dv/dt Capability
- · ESD Improved Capability
- RoHS Compliant

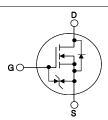
Applications

- LCD/LED TV
- Lighting
- Uninterruptible Power Supply
- · AC-DC Power Supply

Description

UniFETTM II MOSFET is Fairchild Semiconductor[®]'s high voltage MOSFET family based on advanced planar stripe and DMOS technology. This advanced MOSFET family has the smallest on-state resistance among the planar MOSFET, and also provides superior switching performance and higher avalanche energy strength. In addition, internal gate-source ESD diode allows UniFET II MOSFET to withstand over 2kV HBM surge stress. The body diode's reverse recovery performance of UniFET II FRFET® MOSFET has been enhanced by lifetime control. Its t_{rr} is less than 100nsec and the reverse dv/dt immunity is 15V/ns while normal planar MOSFETs have over 200nsec and 4.5V/nsec respectively. Therefore, it can remove additional component and improve system reliability in certain applications in which the performance of MOSFET's body diode is significant. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol		Parameter			Unit
V _{DSS}	Drain to Source Voltage			500	V
V _{GSS}	Gate to Source Voltage			±25	V
ı	Drain Current	- Continuous (T _C = 25°C)		7*	Λ.
'D	Diam Current	- Continuous (T _C = 100°C)		4.2*	Α
I _{DM}	Drain Current	- Pulsed	(Note 1)	28*	Α
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		(Note 2)	93	mJ
I _{AR}	Avalanche Current		(Note 1)	7	Α
E _{AR}	Repetitive Avalanche Energy		(Note 1)	13	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	20	V/ns
D	Dower Dissipation	$(T_C = 25^{\circ}C)$		40	W
P_{D}	Power Dissipation	- Derate above 25°C		0.32	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

^{*}Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FDPF8N50NZF	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	3.1	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDPF8N50NF	FDPF8N50NZF	TO-220F	=	=	50

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu A, V_{GS} = 0V, T_C = 25^{\circ}C$	500	-	-	V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.5	-	V/°C
	Zero Gate Voltage Drain Current	$V_{DS} = 500V, V_{GS} = 0V$	-	-	10	μА
IDSS	Zeio Gate voltage Dialli Cullent	$V_{DS} = 400V, T_{C} = 125^{\circ}C$	-	-	100	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 25V, V_{DS} = 0V$	-	-	±10	μΑ

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu A$	3.0	-	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 3.5A$	-	0.85	1	Ω
g _{FS}	Forward Transconductance	$V_{DS} = 20V, I_{D} = 3.5A$	-	6.3	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz		565	735	pF
C _{oss}	Output Capacitance			80	105	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/12	-	5	8	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	14	18	nC
Q _{gs}	Gate to Source Gate Charge	$V_{DS} = 400V, I_{D} = 7A$	-	4	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	$V_{GS} = 10V$ (Note 4)	-	6	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	17	45	ns
t _r	Turn-On Rise Time	$V_{DD} = 250V$, $I_D = 7A$	-	34	80	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25\Omega$, $V_{GS} = 10V$	-	43	95	ns
t _f	Turn-Off Fall Time	(Note 4)	-	27	60	ns

Drain-Source Diode Characteristics

IS	Maximum Continuous Drain to Source Diode Forward Current		-	-	7	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	28	Α
V_{SD}	Drain to Source Diode Forward Voltage V _{GS} = 0V, I _{SD} = 7A		-	-	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 7A	-	80	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	0.3	-	μС

- **Notes:**1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 3.8mH, I_{AS} = 7A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 3. I_{SD} \leq 7A, di/dt \leq 200A/ μ s, V_{DD} \leq BV $_{DSS}$, Starting T $_{J}$ = 25°C
- 4. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

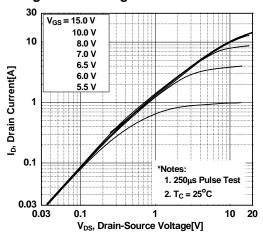


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

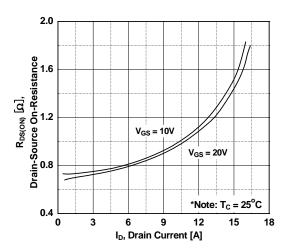


Figure 5. Capacitance Characteristics

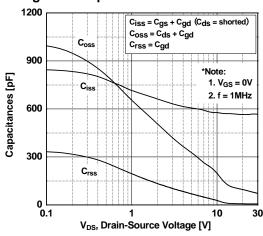


Figure 2. Transfer Characteristics

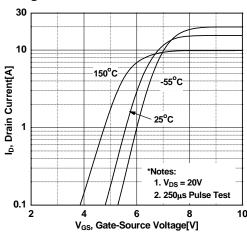


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

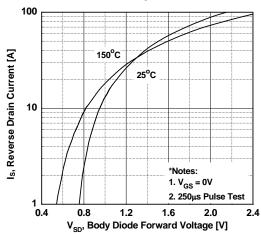
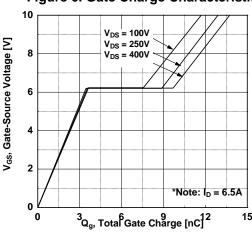


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

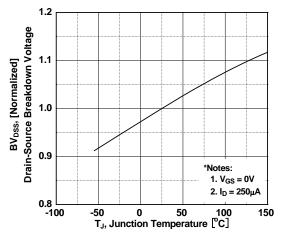


Figure 8. Maximum Safe Operating Area - FDPF8N50NZF

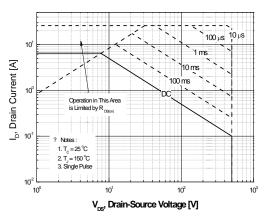


Figure 9. Maximum Drain Current vs. Case Temperature

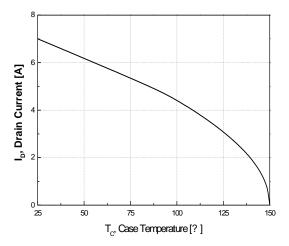
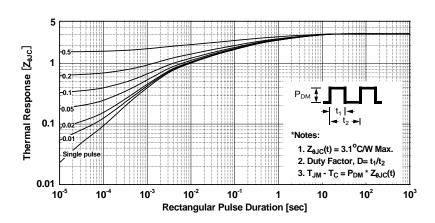
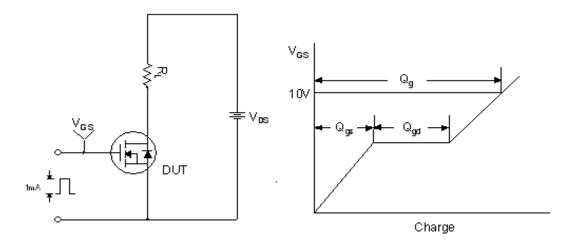


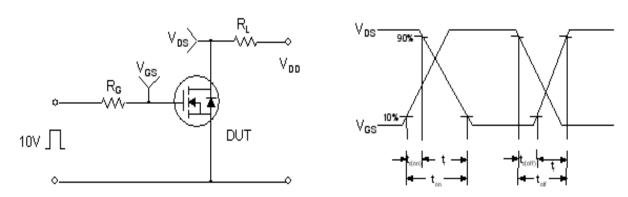
Figure 11. Transient Thermal Response Curve -FDPF8N50NZF



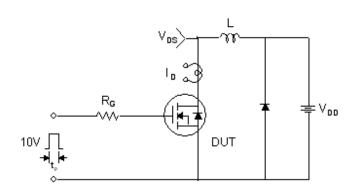
Gate Charge Test Circuit & Waveform

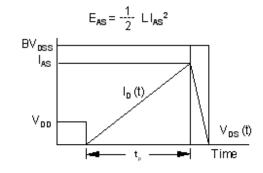


Resistive Switching Test Circuit & Waveforms

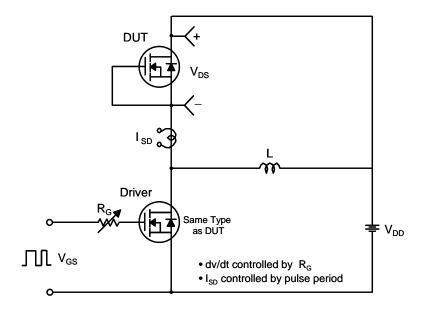


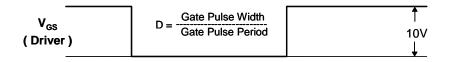
Unclamped Inductive Switching Test Circuit & Waveforms

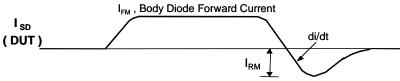




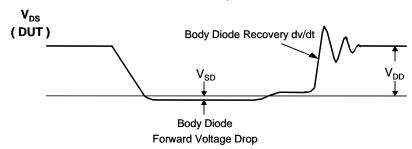
Peak Diode Recovery dv/dt Test Circuit & Waveforms





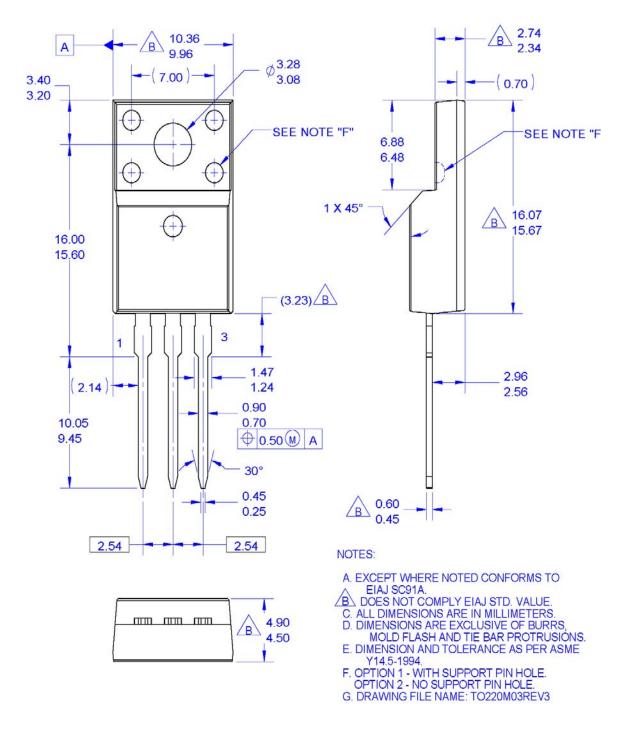


Body Diode Reverse Current



Package Dimensions

TO-220M03







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